

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/642,810	EKKERT, LEN	
Examiner		Art Unit		Page 1 of 1
Niki M. Eloshway		3727		

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,216,875	08-1980	Stanish, Walter F.	220/212
	B	US-3,624,787	11-1971	Newman, Yetty	220/212
	C	US-5,695,084	12-1997	Chmela et al.	220/212
	D	US-5,775,531	07-1998	Lowry, James W.	220/212.5
	E	US-5,992,667	11-1999	Huang, Shou-Li	220/212
	F	US-6,116,450	09-2000	Huang, Shou Li	220/212
	G	US-6,604,645	08-2003	Vaupotic, Vladimir	220/212
	H	US-5,705,212	01-1998	Atkinson, Patrick J.	426/115
	I	US-2,942,752	06-1960	BRUNEL BERNARD A C	220/212
	J	US-5,706,974	01-1998	Murdick et al.	220/735
	K	US-3,618,751	11-1971	Rich, Ernest J.	206/219
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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